

SBAS014A - MARCH 1992 - REVISED SEPTEMBER 2010

# 12-Bit, 800kHz Sampling CMOS ANALOG-TO-DIGITAL CONVERTER

Check for Samples: ADS7810

# **FEATURES**

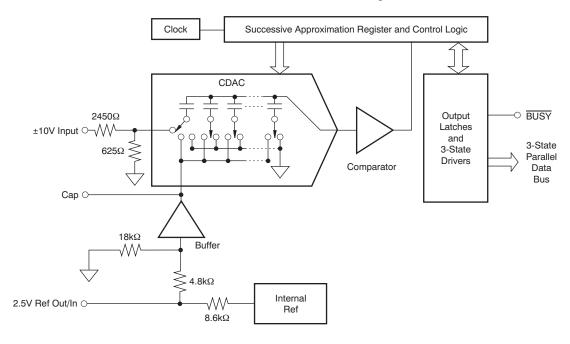
- 1.25µs Throughput Time
- Standard ±10V Input Range
- 69dB Min SINAD With 250kHz Input
- ±3 LSB Max INL and ±3 LSB Max DNL
- **Internal Reference**
- Complete With S/H, REF, CLOCK, ETC.
- Parallel Data w/Latches
- 28-PIN SOIC Package

## DESCRIPTION

The ADS7810 is a complete 12-bit sampling analog-to-digital converter (A/D) using state-of-the-art CMOS structures. It contains a complete 12-bit capacitor-based SAR A/D with inherent S/H, reference, clock, interface for microprocessor use, and 3-state output drivers.

The ADS7810 is specified at an 800kHz sampling rate, and ensured over the full temperature range. provide Laser-trimmed scaling resistors industry-standard ±10V input range, while an innovative design allows operation from ±5V supplies.

The 28-pin ADS7810 is available in a plastic SOIC fully specified for operation over the industrial -40°C to +70°C range.



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

# ORDERING INFORMATION

For the most current package and ordering information, see the Package Option Addendum located at the end of this data sheet, or see the device product folder at www.ti.com.

# **ABSOLUTE MAXIMUM RATINGS(1)**

Over operating free-air temperature range (unless otherwise noted).

	ADS7810	UNIT
Analog inputs: V <sub>IN</sub>	±25	V
	+V <sub>ANA</sub> +0.3 to AGND2 -0.3	V
	Indefinite Short to AGND2 Momentary Short to +V <sub>ANA</sub>	V
Ground voltage differences: DGND, AGND1, AGND2	±0.3	V
+V <sub>ANA</sub>	+7	V
+V <sub>DIG</sub> to +V <sub>ANA</sub>	+0.3	V
+V <sub>DIG</sub>	+7	V
-V <sub>ANA</sub>	-7	V
Digital inputs	-0.3 to +V <sub>DIG</sub> +0.3	V
Maximum junction temperature	+165	°C
Internal power dissipation	825	mW

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum rated conditions for extended periods may affect device reliability.

# **ELECTRICAL CHARACTERISTICS**

At  $T_A = -40$ °C to +70°C,  $f_S = 800$ kHz, + $V_{DIG} = +V_{ANA} = +5V$ , - $V_{ANA} = -5V$ , using internal reference and the 50 $\Omega$  input resistor shown in Figure 16, unless otherwise specified.

DADAME	TED	TEST CONDITIONS	Al	DS7810U		AD	S7819UB <sup>(1)</sup>		LINUT
PARAME	IEK	TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
RESOLUTION					12			12	Bits
ANALOG INPUT								<u> </u>	
Voltage range		+ln - (-ln)		±10			±10		V
Impedance				3.1			3.1		kΩ
Capacitance				5			5		pF
THROUGHPUT SP	EED				I				
Conversion cycle		$t_3 + t_4$		1020			1020		ns
Complete cycle		Acquire and convert			1250			1250	ns
Throughput rate			800			800			kHz
DC ACCURACY		-							
Integral linearity erro	or				±3			±2	LSB
Differential linearity					±3			±3	LSB
No missing codes				Ensured			Ensured		
Transition noise <sup>(2)</sup>				0.1			0.1		LSB
Full-scale error <sup>(3)(4)</sup>					±1			±0.75	%
Full-scale error drift				±12			±12		ppm/°C
Full-scale error <sup>(3)(4)</sup>		Ext. 2.5000V Ref			±1			±1	%
Full-scale error drift		Ext. 2.5000V Ref		±12			±12		ppm/°C
Bipolar zero error <sup>(3)</sup>					±8			±4	LSB
Bipolar zero error d				±2			±2		ppm/°C
Power-supply sensi		+4.75V < V <sub>D</sub> < +5.25V			±5			±5	LSB
$(+V_{DIG} = +V_{ANA} = V_D)$		-5.25V < -V <sub>ANA</sub> < -4.75V			±0.5			±0.5	LSB
AC ACCURACY		OHO							
Spurious-free dynar	mic range	f <sub>IN</sub> = 250kHz	74	82		77	84		dB <sup>(5)</sup>
Total harmonic disto		f <sub>IN</sub> = 250kHz		-80	-74		-82	-77	dB
Signal-to-(noise+dis	stortion)	f <sub>IN</sub> = 250kHz	67	71		69	71		dB
Signal-to-noise	,	f <sub>IN</sub> = 250kHz	66	71		70	71		dB
Usable bandwidth <sup>(6)</sup>	)			1.5			1.5		MHz
SAMPLING DYNAM	MICS							-	
Aperture delay				20			20		ns
Aperture jitter				10			10		ps
Transient response		Full-scale step		200			200		ns
Overvoltage recove				250			250		ns
REFERENCE	,								
Internal reference v	oltage		2.48	2.5	2.52	2.48	2.5	2.52	V
Internal reference d current (external load shoul	c source			100			100		μА
Internal reference d				8			8		ppm/°C
External reference voltage range for specified linearity			2.3	2.5	2.7	2.3	2.5	2.7	V
External reference	current drain	Ext. 2.5000V Ref			100			100	μА
DIGITAL INPUTS			L						
	V <sub>IL</sub>		-0.3		+0.8	-0.3		+0.8	V
	V <sub>IH</sub>		+2.4		V <sub>D</sub> + 0.3	+2.4		V <sub>D</sub> + 0.3	V
Logic levels	I <sub>IL</sub>	V <sub>IL</sub> = 0V			±10			±10	μА
	I <sub>IH</sub>	V <sub>IH</sub> = 5V			±10			±10	v

- (1) Shaded cells indicate same specifications as the ADS7810U.
- (2) Typical rms noise at worst-case transitions and temperatures.
- 3) Measured with 50Ω in series with analog input. Adjustable to zero with external potentiometer.
- (4) Full-scale error is the worst case of —Ful-Scale or +Full-Scale untrimmed deviation from ideal first and last code transitions, divided by the transition voltage (not divided by the full-scale range) and includes the effect of offset error.
- (5) All specifications in dB are referred to a full-scale ±10V input.
- (6) Usable bandwidth defined as Full-Scale input frequency at which Signal-to-(Noise+Distortion) degrades to 60dB, or 10 bits of accuracy.
- (7) Recovers to specified performance after 2 x FS input over voltage.



# **ELECTRICAL CHARACTERISTICS (continued)**

At  $T_A = -40$ °C to +70°C,  $f_S = 800$ kHz, + $V_{DIG} = +V_{ANA} = +5V$ , - $V_{ANA} = -5V$ , using internal reference and the 50 $\Omega$  input resistor shown in Figure 16, unless otherwise specified.

DADAME	TED	TEST CONDITIONS	A	DS7810U		AD	S7819UB <sup>(1)</sup>		UNIT
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
DIGITAL OUTPUTS	1				·				
Data format			Pa	rallel 12 bits		Pa	rallel 12 bits		
			Binary t	wos compleme	nt	Binary t	wos compleme	nt	
Data coding	V <sub>OL</sub>	I <sub>SINK</sub> = 1.6mA			+0.4			+0.4	V
Data coding	V <sub>OH</sub>	I <sub>SOURCE</sub> = 500μA	+2.8			+2.8			V
Leakage current		High-Z state, V <sub>OUT</sub> = 0V to V <sub>DIG</sub>			±5			±5	μА
Output capacitance		High-Z state			15			15	pF
DIGITAL TIMING					·				
Bus access time					62			62	ns
Bus relinquish time					83			83	ns
POWER SUPPLIES								'	
	+V <sub>DIG</sub> = +V <sub>ANA</sub>		+4.75	+5	+5.25	+4.75	+5	+5.25	V
Specified	-V <sub>ANA</sub>		-5.25	-5	-4.75	-5.25	-5	-4.75	V
performance	+I <sub>DIG</sub>			+16			+16		mA
	+I <sub>ANA</sub>			+16			+16		mA
	-I <sub>ANA</sub>			-13			-13		mA
Derated	+V <sub>DIG</sub> = +V <sub>ANA</sub>		+4.5	+5	+5.5	+4.5	+5	+5.5	٧
performance	-V <sub>ANA</sub>		-5.5	-5	-4.5	-5.5	-5	-4.5	V
Power dissipation		f <sub>S</sub> = 800kHz		225	275		225	275	mW
TEMPERATURE RA	ANGE		·					•	
Specified performan	се		-40		+70	-40		+70	°C
Derated performance Storage			-55		+125	-55		+125	°C
			-65		+150	-65		+150	°C
Thermal resistance	Plastic DIP			75			75		°C/W
$(\theta_{JA})$	SOIC			75			75		°C/W



# **TIMING INFORMATION**

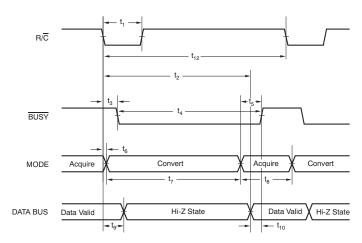


Figure 1. Conversion Timing with Outputs Enabled After Conversion (CS Tied Low)

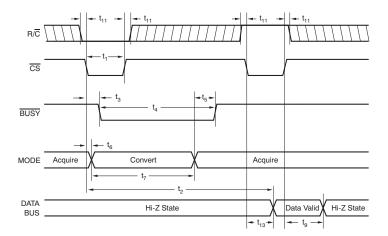


Figure 2. Using  $\overline{\text{CS}}$  to Control Conversion and Read Timing

# TIMING REQUIREMENTS ( $T_{MIN}$ to $T_{MAX}$ )

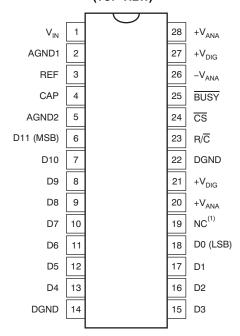
SYMBOL	DESCRIPTION	MIN	TYP	MAX	UNIT
t <sub>1</sub>	Convert pulse width	40			ns
t <sub>2</sub>	Data valid delay after R/C low		955	1095	ns
t <sub>3</sub>	BUSY delay from R/C low		70	125	ns
t <sub>4</sub>	BUSY low		950	1080	ns
t <sub>5</sub>	BUSY delay after end of conversion		90		ns
t <sub>6</sub>	Aperture delay		20		ns
t <sub>7</sub>	Conversion time		910	1020	ns
t <sub>8</sub>	Acquisition time		200	230	ns
t <sub>7</sub> , t <sub>8</sub>	Throughput time		1110	1250	ns
t <sub>9</sub>	Bus relinquish time	10	50	83	ns
t <sub>10</sub>	BUSY delay after data valid	20	65	120	ns
t <sub>11</sub>	R/C to CS setup time	10			ns
t <sub>12</sub>	Time between conversions	1250			ns
t <sub>13</sub>	Bus access time	10	25	62	ns

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# **PIN CONFIGURATION**

#### DW PACKAGE SOIC-28 (TOP VIEW)



(1) Not internally connected.

# **PIN ASSIGNMENTS**

	PIN	DIGITAL	DECORPTION					
NO.			DESCRIPTION					
1	V <sub>IN</sub>		Analog input. Connect via $50\Omega$ to analog input. Full-scale input range is $\pm 10$ V.					
2	AGND1		Analog ground. Used internally as ground reference point. Minimal current flow.					
3	REF		Reference input/output. Outputs internal reference of +2.5V nominal. Can also be driven by external system reference. In both cases, decouple to ground with a $0.1\mu F$ ceramic capacitor.					
4	CAP		Reference buffer output. $10\mu F$ tantalum capacitor to ground. Nominally +2V.					
5	AGND2		Analog ground.					
6	D11 (MSB)	0	Data bit 11. Most significant bit (MSB) of conversion results. Hi-Z state when $\overline{\text{CS}}$ is high, or when R/ $\overline{\text{C}}$ is low, or when a conversion is in progress.					
7	D10	0	Data bit 10. Hi-Z state when $\overline{\text{CS}}$ is high, or when R/ $\overline{\text{C}}$ is low, or when a conversion is in progress.					
8	D9	0	Data bit 9. Hi-Z state when $\overline{\text{CS}}$ is high, or when R/ $\overline{\text{C}}$ is low, or when a conversion is in progress.					
9	D8	0	Data bit 8. Hi-Z state when $\overline{\text{CS}}$ is high, or when $R/\overline{C}$ is low, or when a conversion is in progress.					
10	D7	0	Data bit 7. Hi-Z state when $\overline{\text{CS}}$ is high, or when $R/\overline{C}$ is low, or when a conversion is in progress.					
11	D6	0	Data bit 6. Hi-Z state when $\overline{\text{CS}}$ is high, or when R/ $\overline{\text{C}}$ is low, or when a conversion is in progress.					
12	D5	0	Data bit 5. Hi-Z state when $\overline{\text{CS}}$ is high, or when $R/\overline{C}$ is low, or when a conversion is in progress.					
13	D4	0	Data bit 4. Hi-Z state when $\overline{\text{CS}}$ is high, or when $R/\overline{C}$ is low, or when a conversion is in progress.					
14	DGND		Digital ground.					
15	D3	0	Data bit 3. Hi-Z state when $\overline{\text{CS}}$ is high, or when $R/\overline{C}$ is low, or when a conversion is in progress.					

# PIN ASSIGNMENTS (continued)

Р	PIN	DIGITAL	DEGODIDATION
NO.	NAME	1/0	DESCRIPTION
16	D2	0	Data bit 2. Hi-Z state when $\overline{\text{CS}}$ is high, or when R/ $\overline{\text{C}}$ is low, or when a conversion is in progress.
17	D1	0	Data bit 1. Hi-Z state when $\overline{\text{CS}}$ is high, or when R/ $\overline{\text{C}}$ is low, or when a conversion is in progress.
18	D0 (LSB)	0	Data bit 0. Least significant bit (LSB) of conversion results. Hi-Z state when $\overline{\text{CS}}$ is high, or when R/ $\overline{\text{C}}$ is low, or when a conversion is in progress.
19	NC		Not internally connected.
20	+V <sub>ANA</sub>		Analog positive supply input. Nominally +5V. Connect directly to pins 21, 27, and 28.
21	+V <sub>DIG</sub>		Digital supply input. Nominally +5V. Connect directly to pins 20, 27, and 28.
22	DGND		Digital ground.
23	R/C	I	Read/Convert input. With $\overline{CS}$ low, a falling edge on R/ $\overline{C}$ puts the internal sample/hold into the hold state and starts a conversion. With $\overline{CS}$ low and no conversion in progress, a rising edge on R/ $\overline{C}$ enables the output data bits.
24	CS	I	Chip select. With $R/\overline{C}$ low, a falling edge on $\overline{CS}$ will initiate a conversion. With $R/\overline{C}$ high and no conversion in progress, a falling edge on $\overline{CS}$ will enable the output data bits.
25	BUSY	0	Busy output. Falls when a conversion is started, and remains low until the conversion is completed and the data are latched into the output register. With $\overline{CS}$ low and $R/\overline{C}$ high, output data will be valid when $\overline{BUSY}$ rises, so that the rising edge can be used to latch the data.
26	-V <sub>ANA</sub>		Analog negative supply input. Nominally –5V. Decouple to ground with $0.1\mu F$ ceramic and $10\nu F$ tantalum capacitors.
27	+V <sub>DIG</sub>		Digital supply input. Nominally +5V. Connect directly to pins 20, 21, and 28.
28	+V <sub>ANA</sub>		Analog positive supply input. Nominally +5V. Connect directly to pins 20, 21, and 27, and decouple to ground with $0.1\mu F$ ceramic and $10\mu F$ tantalum capacitors.



## TYPICAL CHARACTERISTICS

At  $T_A = +25$ °C,  $f_S = 800$ kHz,  $+V_{DIG} = +V_{ANA} = +5V$ ,  $-V_{ANA} = -5V$ , using internal reference and the  $50\Omega$  input resistors as shown in Figure 16, unless otherwise specified.

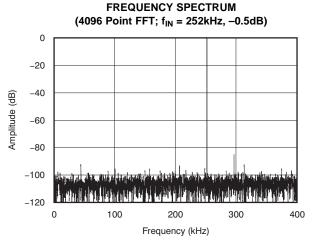


Figure 3.

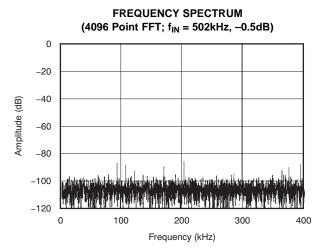


Figure 4.

# FREQUENCY SPECTRUM (4096 Point FFT; f<sub>IN</sub> = 1002kHz, -0.5dB)

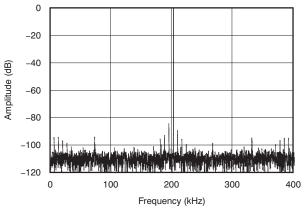


Figure 5.

# 

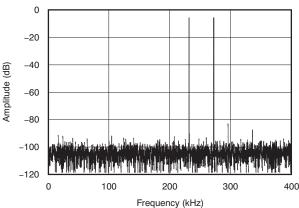


Figure 6.

# SIGNAL-TO-(NOISE + DISTORTION) vs INPUT FREQUENCY (f<sub>IN</sub> = -0.5dB)

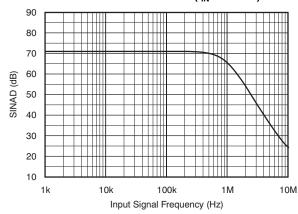


Figure 7.

# AC PARAMETERS vs TEMPERATURE (f<sub>IN</sub> = 250kHz, -0.5dB)

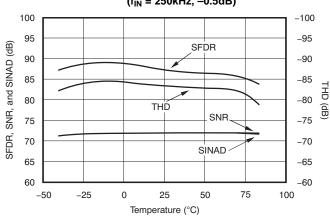
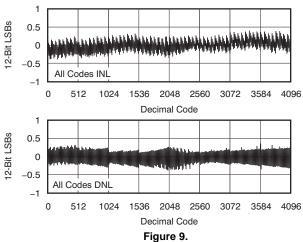


Figure 8.



# **TYPICAL CHARACTERISTICS (continued)**

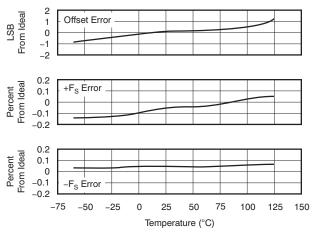
At  $T_A = +25$ °C,  $f_S = 800$ kHz,  $+V_{DIG} = +V_{ANA} = +5V$ ,  $-V_{ANA} = -5V$ , using internal reference and the  $50\Omega$  input resistors as shown in Figure 16, unless otherwise specified.



Analog Input Voltage: Expected Code Center (LSBs)

Figure 10.





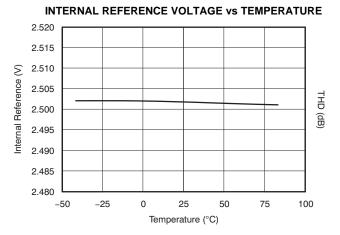
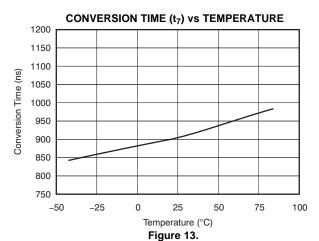


Figure 11. Figure 12.





#### APPLICATION INFORMATION

#### **BASIC OPERATION**

Figure 14 shows a basic circuit to operate the ADS7810. Taking R/C (pin 23) low for a minimum of 40ns will initiate a conversion. BUSY (pin 25) will go low and stay low until the conversion is completed and the output registers are updated. Data will be output in binary twos complement with the MSB on D11 (pin 6). BUSY going high can be used to latch the data. All convert commands will be ignored while BUSY is low.

The ADS7810 will begin tracking the input signal at the end of the conversion. Allowing  $1.25\mu s$  between convert commands assures accurate acquisition of a new signal.

## STARTING A CONVERSION

The combination of  $\overline{CS}$  (pin 24) and R/ $\overline{C}$  (pin 23) low for a minimum of 40ns puts the sample/hold of the ADS7810 in the hold state and starts a conversion.  $\overline{BUSY}$  (pin 25) will go low and stay low until the conversion is completed and the internal output register has been updated. All new convert commands during  $\overline{BUSY}$  low will be ignored.

The ADS7810 will begin tracking the input signal at the end of the conversion. Allowing  $1.25\mu s$  between convert commands assures accurate acquisition of a new signal. Refer to Table 1 for a summary of  $\overline{CS}$ , R/C, and  $\overline{BUSY}$  states, and Figure 1 and Figure 2 for timing parameters.

 $\overline{\text{CS}}$  and R/ $\overline{\text{C}}$  are internally OR'd and level triggered. There is not a requirement which input goes low first when initiating a conversion. If it is critical that  $\overline{\text{CS}}$  or R/ $\overline{\text{C}}$  initiate the conversion, be sure the less critical input is low at least 10ns prior to the initiating input.

To reduce the number of control pins,  $\overline{CS}$  can be tied low using  $R/\overline{C}$  to control the read and convert modes. Note that the parallel output will be active whenever  $R/\overline{C}$  is HIGH and no conversion is in progress. See the *Reading Data* section and refer to Table 1 for control line functions for 'read' and 'convert' modes.

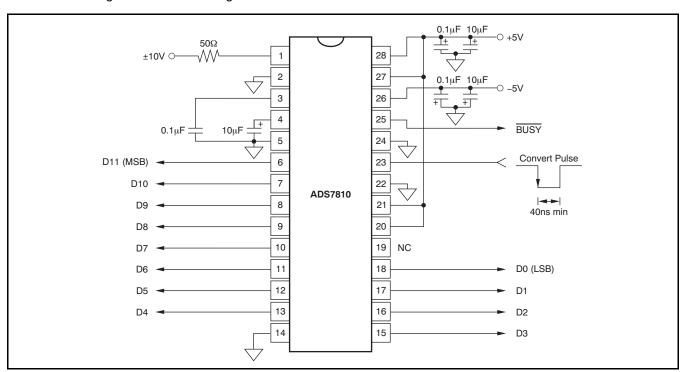


Figure 14. Basic Operation



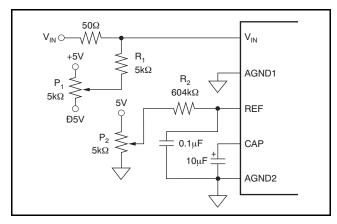
#### **READING DATA**

The ADS7810 outputs full parallel data in binary twos complement data format. The parallel output will be active when  $R/\overline{C}$  (pin 23) is high,  $\overline{CS}$  (pin 24) is low, and no conversion is in progress. Any other combination will 3-state the parallel output. Valid conversion data can be read in a full parallel, 12-bit word on D11-D0 (pins 6-13 and 15- 18). Refer to Table 2 for ideal output codes.

After the conversion is completed and the output registers have been updated, BUSY (pin 25) will go high. Valid data from the most recent conversion will be available on D11-D0 (pins 6-13 and 15-18). BUSY going high can be used to latch the data. Refer to Timing Requirements as well as Figure 1 and Figure 2.

**NOTE:** For the best performance, the external data bus connected to D11-D0 should not be active during a conversion. The switching noise of the external asynchronous data signals can cause digital feedthrough degrading the converter performance.

The number of control lines can be reduced by tying CS low while using R/C to initiate conversions and activate the output mode of the converter. See Figure 1.



Note: Use 1% metal film resistors. Trim offset at 0V first, then trim gain at 10V.

Figure 15. Circuit Diagram with External Hardware Trim

#### **INPUT RANGES**

The ADS7810 offers a standard ±10V input range. Figure 15 and Figure 16 show the necessary circuit connections for the ADS7810 with and without trim. Offset and full-scale external specifications are tested and ensured with the  $50\Omega$ resistor shown in Figure 16. This external resistor makes it possible to trim the offset ±50mV using a trim pot or trim DAC. This resistor may be left out if the offset and gain errors will be corrected in software or if they are negligible in regards to the particular application. See the Calibration section of the data sheet for details.

The nominal input impedance of 3.125kW results from the combination of the internal resistor network shown on the front page of the product data sheet and external  $50\Omega$  resistor. The input resistor divider network provides inherent overvoltage protection ensured to at least  $\pm 25$ V. The  $50\Omega$ , 1% resistor does not compromise the accuracy or drift of the converter. It has little influence relative to the internal resistors, and tighter tolerances are not required.

**NOTE:** The values shown for the internal resistors are for reference only. The exact values can vary by ±30%. This is true of all resistors internal to the ADS7810. Each resistive divider is trimmed so that the proper division is achieved.

 Full-scale error includes offset and gain errors measured at both +FS and -FS.

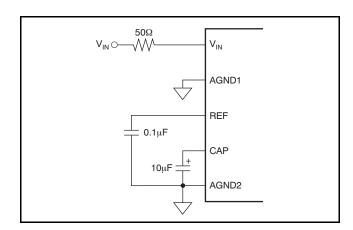


Figure 16. Circuit Diagram without External Hardware Trim



Table 1. Control Line Functions for 'Read' and 'Convert'

CS	R/C	BUSY	OPERATION
1	X	X	None. Databus in Hi-Z state.
<b>↓</b>	0	1	Initiates conversion. Databus remains in Hi-Z state.
0	<b>↓</b>	1	Initiates conversion. Databus enters Hi-Z state.
0	1	<b>↑</b>	Conversion completed. Valid data from the most recent conversion on the databus.
<b>\</b>	1	1	Enables databus with valid data from the most recent conversion.
1	1	0	Conversion in progress. Databus in Hi-Z state, enabled when the conversion is completed.
0	1	0	Conversion in progress. Databus in Hi-Z state, enabled when the conversion is completed.
0	0	1	Conversion completed. Valid data from the most recent conversion in the output register, but output pins D11-D0 are 3-stated.
Х	Х	0	New convert commands ignored. Conversion in progress.

Table 2. Ideal Input Voltages and Output Codes

DESCRIPTION	ANALOG VALUE	DIGITAL OUTPUT BINARY TWOS COMPLEMENT									
Full-Scale Range	±10V										
Least Significant Bit (LSB)	4.88mV	BINARY CODE	HEX CODE								
+Full-Scale (10V – 1LSB)	9.995V	0111 1111 1111	7FF								
Midscale	0V	0000 0000 0000	000								
One LSB below Midscale	–4.88mV	1111 1111 1111	FFF								
-Full-Scale	-10V	1000 0000 0000	800								

## **CALIBRATION**

The ADS7810 can be trimmed in hardware or software. The offset should be trimmed before the gain since the offset directly affects the gain.

#### **Hardware Calibration**

To calibrate the offset and gain of the ADS7810, install the proper resistors and potentiometers as shown in Figure 15. The calibration range is ±50mV for bipolar zero and ±120mV for full scale.

Potentiometer  $P_1$  and resistor  $R_1$  form the offset adjust circuit and  $P_2$  and  $R_2$  the gain adjust circuit. The exact values are not critical.  $R_1$  and  $R_2$  should not be made any larger than the value shown. They can easily be made smaller to provide increased adjustment range. Reducing these below 15% of the indicated values could begin to adversely affect the operation of the converter.

 $P_1$  and  $P_2$  can also be made larger to reduce power dissipation. However, larger resistances will push the useful adjustment range to the edges of the potentiometer.  $P_1$  should probably not exceed  $20k\Omega$  and  $P_2$   $100k\Omega$  in order to maintain reasonable sensitivity.

#### Software Calibration

To calibrate the offset and gain of the ADS7810, no external resistors are required. See the *No Calibration* section for details on the effects of the external resistor.

#### No Calibration

See Figure 16 for circuit connections. Note that the actual voltage dropped across the  $50\Omega$  resistor is nearly two orders of magnitude lower than the voltage dropped across the internal resistor divider network. This should be taken into consideration when choosing the accuracy and drift specifications of the external resistors. In most applications, 1% metal-film resistors will be sufficient.

The external  $50\Omega$  resistor shown in Figure 16 may not be necessary in some applications. This resistor provides trim capability for the offset and compensates for a slight gain adjustment internal to the ADS7810. Not using the  $50\Omega$  resistor will cause a small gain error but will have no effect on the inherent offset error. Figure 17 shows typical transfer function characteristics with and without the  $50\Omega$  resistor in the circuit.

#### REFERENCE

The ADS7810 can operate with its internal 2.5V reference or an external reference. By applying an external reference to pin 3, the internal reference can be bypassed. The reference voltage at REF is buffered internally and output on CAP (pin 4).

## **REF**

REF (pin 3) is an input for an external reference or the output for the internal 2.5V reference. A  $0.1\mu F$  capacitor should be connected as close to the REF pin as possible. The capacitor and the output resistance of REF create a low pass filter to band

limit noise on the reference. Using a smaller value capacitor will introduce more noise to the reference degrading the SNR and SINAD. The internal reference should not be used to sink or source currents greater than 100mA. In addition, all external loads should be static.

The range for the external reference is 2.3V to 2.7V and determines the actual LSB size. Increasing the reference voltage will increase the full-scale range and the LSB size of the converter which can improve the SNR.

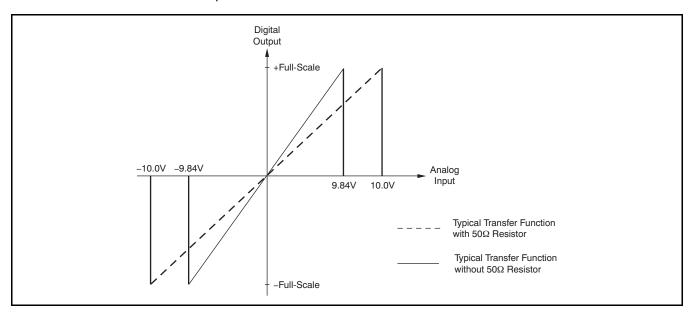


Figure 17. Comparison of the ADS7810 Transfer Function with and without the  $50\Omega$  Series Resistor on  $V_{\text{IN}}$ 



## **CAP**

CAP (pin 4) is the output of the internal reference buffer. A  $10\mu F$  tantalum capacitor should be placed as close to the CAP as possible to provide optimum switching currents for the CDAC throughout the conversion cycle and compensation for the output of the buffer. Using a capacitor any smaller than  $1\mu F$  can cause the output buffer to oscillate and may not have sufficient charge for the CDAC. Capacitor values larger than  $10\mu F$  will have little effect on improving performance. The voltage on the CAP pin is approximately 2V when using the internal reference, or 80% of an externally supplied reference.

#### **LAYOUT**

#### **POWER**

The ADS7810 uses the majority of its power for analog and static circuitry, and it should be considered as an analog component. For optimum performance, tie the analog and digital +5V power pins to the same +5V power supply and tie the analog and digital grounds together.

For best performance, the  $\pm 5V$  supplies can be produced from whatever analog supply is used for the rest of the analog signal conditioning. If  $\pm 12V$  or  $\pm 15V$  supplies are present, simple regulators can be used. The +5V power for the A/D should be separate from the +5V used for the system's digital logic. Connecting  $+V_{DIG}$  (pin 27) directly to a digital supply can reduce converter performance due to switching noise from the digital logic.

Although it is not suggested, if the digital supply must be used to power the converter, be sure to properly filter the supply. Either using a filtered digital supply or a regulated analog supply, both  $V_{DIG}$  and  $V_{ANA}$  should be tied to the same +5V source.

#### **GROUNDING**

Three ground pins are present on the ADS7810. DGND (pin 22) is the digital supply ground. AGND2 (pin 5) is the analog supply ground. AGND1 (pin 2) is the ground which all analog signals internal to the A/D are referenced. AGND1 is more susceptible to current induced voltage drops and must have the path of least resistance back to the power supply.

All the ground pins of the ADS should be tied to the analog ground plane, separated from the system digital logic ground, to achieve optimum performance.

Both analog and digital ground planes should be tied to the *system* ground as near to the power supplies as possible. This helps to prevent dynamic digital ground currents from modulating the analog ground through a common impedance to power ground.

#### SIGNAL CONDITIONING

The FET switches used for the sample hold on many CMOS A/D converters release a significant amount of charge injection which can cause the driving op amp to oscillate. The resistive front end of the ADS7810 attenuates this charge and reduces its magnitude significantly—reducing the burden on the external input amplifier or buffer.

However, keep in mind that maintaining signal integrity at voltage swings of ±10V and frequencies of several hundred kilohertz is extremely challenging. In addition, the external input amplifier must drive the ADS7810 mainly during its sample period—roughly 200ns. This will require a highspeed, precision amplifier which can swing to greater than ±10V.

For signals where the predominant frequencies are below 200kHz, the OPA671 operational amplifier should be adequate for most applications. In some cases or where input frequencies are higher, a composite configuration of the OPA671 and BUF634 (in its wide bandwidth mode) may be the best choice. See the BUF634 data sheet for more information.

The resistive front end of the ADS7810 also provides an ensured ±25V over voltage protection. In most cases, this eliminates the need for external input protection circuitry.

# **INTERMEDIATE LATCHES**

The ADS7810 does have 3-state outputs for the parallel port, but intermediate latches should be used if the bus will be active during conversions. If the bus is not active during conversions, the 3-state outputs can be used to isolate the A/D from other peripherals on the same bus.

Intermediate latches are beneficial on any monolithic A/D converter. The ADS7810 has an internal LSB size of 610mV. Transients from fast switching signals on the parallel port, even when the A/D is 3-stated, can be coupled through the substrate to the analog circuitry causing degradation of converter performance.

# **REVISION HISTORY**

CI	hanges from Original (March, 1998) to Revision A	Page
•	Updated document format to meet current standards	1
•	Updated Features list item indicating max INL and DNL specifications	1
•	Changed indicated temperature range in Description section	1
•	Updated Ordering Information table	2
•	Changed temperature range for Electrical Characteristics measurement conditions	3
•	Changed ADS7810U integral linearity error to ±3 LSB	3
•	Changed ADS7810UB integral linearity error to ±3 LSB	3
•	Changed differential linearity error for both ADS7810U and ADS7810UB to ±3 LSB	3
•	Changed ADS7810U full-scale error to ±3 LSB	3
•	Changed ADS7810UB full-scale error to ±3 LSB	3
•	Changed ADS7810U full-scale error with ext.2.5V Ref to ±1 LSB	3
•	Changed ADS7810UB full-scale error with ext.2.5V Ref to ±1 LSB	3
•	Changed temperature range for Electrical Characteristics measurement conditions	
•	Changed specified temperature range to -40°C to +70°C	4



# PACKAGE OPTION ADDENDUM

15-Jun-2019

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
ADS7810U	LIFEBUY	SOIC	DW	28	20	Green (RoHS	CU NIPDAU-DCC	Level-3-260C-168 HR	-40 to 85	ADS7810U	
NEOTOTO C	LII LBOT	0010	511	20	20	& no Sb/Br)	00 Mil B/10 B00	2000 100 1110	40 10 00	В	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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DW (R-PDSO-G28)

# PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AE.



# DW (R-PDSO-G28)

# PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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